

Search Notes

Application/Control No.

10/724,187

Examiner

Robert M. Kunemund

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

1722

SEARCHED

Class	Subclass	Date	Examiner
Search	update	9/13/2005	RMK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
west:silicon substrate plasam clean fluorine		